1-50. (canceled)

51. (previously presented) An integrated circuit comprising:

a supporting structure; and

an enhanced-surface-area electrically conductive ruthenium-containing layer situated on the supporting structure, the ruthenium-containing layer having a non-textured surface adjacent the supporting structure and a textured surface with a mean feature size of at least about 100 Angstroms opposite the non-textured surface.

52. (previously presented) An integrated circuit comprising: a supporting structure; and

an enhanced-surface-area electrically conductive nitrogen-passivated ruthenium-containing layer situated on the supporting structure, the ruthenium-containing layer having a non-textured surface adjacent the supporting structure and a textured surface with a mean feature size of at least about 100 Angstroms opposite the non-textured surface.

53. (previously presented) An integrated circuit comprising: a supporting structure; and

an enhanced-surface-area electrically conductive nitrogen-passivated and oxygen-passivated ruthenium-containing layer situated on the supporting structure, the ruthenium-containing layer having a non-textured surface adjacent the supporting structure and a textured surface with a mean feature size of at least about 100 Angstroms opposite the non-textured surface.

54.-71. (canceled)

72. (previously presented) The integrated circuit of claim 51, wherein the ruthenium-containing layer includes a nitrogen-passivated portion at the textured surface.

73. (previously presented) The integrated circuit of claim 51, wherein the ruthenium-containing layer includes a nitrogen-passivated and oxygen-passivated portion at the textured surface.

74. (new) The integrated circuit of claim 51, wherein the supporting structure is a plug formed in a dielectric material.

75. (new) The integrated circuit of claim 51, wherein the supporting structure includes a plug that extends outwardly from a surface of the supporting structure.

76. (new) The integrated circuit of claim 51, wherein the supporting structure is a plug formed in a dielectric material.

77. (new) The integrated circuit of claim 51, wherein the supporting structure includes a plug that extends outwardly from a surface of the supporting structure.

78. (new) An integrated circuit comprising:
a supporting structure that includes a conductive plug; and
an enhanced-surface-area electrically conductive ruthenium-containing layer situated on
the supporting structure.

- 79. (new) The integrated circuit of claim 78, wherein the conductive plug extends outwardly from the supporting structure.
- 80. (new) The integrated circuit of claim 78, wherein the conductive plug is situated in an opening in a dielectric material.
- 81. (new) The integrated circuit of claim 78, wherein the ruthenium-containing layer has a non-textured surface adjacent the supporting structure and a textured surface with a mean feature size of at least about 100 Angstroms opposite the non-textured surface.